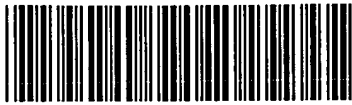


**Search Notes**

Application/Control No.

10/672,381

Examiner

Phu K. Nguyen

Applicant(s)/Patent under  
Reexamination

SHIOYA, HIROYUKI

Art Unit

2628

**SEARCHED**

Class	Subclass	Date	Examiner
Update	search	11/27/2006	PN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update WEST, IEEE, ACM searches	11/27/2006	PN